A Data Analysis Framework for High-variety Product Lines in the Industrial Manufacturing Domain

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Abstract: Industrial manufacturing companies produce a variety of different products, which, despite their differences in function and application area, share common requirements regarding quality assurance and data analysis. The goal of the approach presented in this paper is to automatically generate Extract-Transform-Load (ETL) packages for semi-generic operational database schema. This process is guided by a descriptor table, which allows for identifying and filtering the required attributes and their values. Based on this description model, an ETL process is generated which first loads the data into an entity-attribute-value (EAV) model, then gets transformed into a pivoted model for analysis. The resulting analysis model can be used with standard business intelligence tools. The descriptor table used in the implementation can be substituted with any other non-relational description language, as long as it has the same descriptive capabilities.

1 INTRODUCTION

Data analysis in the industrial manufacturing domain rises some — often contradicting — challenges when compared to traditional business centered data analysis. These challenges, which are addressed in this paper are:

• Use of generic data models in operational databases to represent product variability
• Product specific data analysis models that are feasible for domain experts (in contrast to generic data models without explicit metadata)
• High importance of correlation detection for defect cause analysis in an environment with a huge amount of independent dimensions
• Cope with technical issues like, e.g., repeated measurement for calibration

Unlike conventional data models, which are limited to a specific domain scope, generic data models represent more abstract concepts in order to widen the range of applicability and to a certain degree standardize the way different facts, which share a common structure, are represented in the model. E.g., the pattern bill of material (Jiao et al., 2000) describes a rather generic whole-parts relationship, which is usable for describing a wide range of real world phenomena. The main incentive for using a generic data models is the standardization that goes along with it, i.e., it prevents the creation of different (conventional) data models for the same domain. Especially for data exchange and integration in a business intelligence scenario, mappings need to be established between these different data models which can be error-prone.

One of the most common generic modeling patterns in the relational data model is the Entity-Attribute-Value (EAV) model (Dinuab and Nadkarnia, 2007). The EAV model is used for describing entities that can potentially have a vast amount of attributes, but in a single instance of an entity typically only a few attributes actually occur. For example, in industrial manufacturing, for a given product many measurement types (temperature, pressure, electric resistance, ...) are available and collected during the whole production process, but at a given time only a small subset of the available measurements are actually recorded. The usual approach of reserving one attribute per measurement type in a relational table would lead to many NULL values and as a result to a sparsely filled table. The structure of an EAV table usually consists of three attributes (entity, attribute, value), where entity and attribute form the primary key of the relation. Sometimes, this gets extended with an additional timestamp attribute. Referring to the example above, entity could be a pressure sensor being manufactured, attribute a key value for the measure type "internal resistance", etc.
e.g. "RI", and \textit{value} the real value measured during quality inspection.

One of the biggest downsides of generic data models is that they do not mirror the real world concepts they were designed to represent in a recognizable way, like documentation inherent in the description of the data model via table names, attribute names etc. This is why generic data models heavily rely on outside documentation for users (application developers, business analysts) to make sense off. Especially for data analysis, generic data models need to be transformed to a form that more closely represents the mental image a data analyst has of the domain to be analyzed. For example, in the case of the EAV model, the transformation which brings the data back into a columnar form for analysis is called pivoting (Dinu et al., 2006).

Figure 1 depicts a data schema which is often found in industrial manufacturing, especially in discrete parts manufacturing like the machine and component building industry. Within a product line, the individual products share a lot of similarities, e.g., they are manufactured on the same assembly line and can be represented by a bill-of-materials. Figure 1, these similarities are represented by the master data tables. However, every product is also distinct, in industrial manufacturing most notably the number and kind of measurements taken during the production in order to control the whole process, calibrate the product and assure it meets quality requirements. In figure 1 these differences are represented by the product specific tables, which are connected to the general master data tables through various relations. Note that this approach differs from a strictly generic approach using a EAV model, where all product specific measurements are stored as (entity, attribute, value)-tuples. Such a model is often used, to keep the descriptive quality of the schema as a source of documentation, and also to establish a border between different products within the product line, which usually have a separate domain specialist responsible for just one product. Using this model, a new product gets introduced by building upon the existing master data and add product specific tables which can accommodate all the necessary information. Thus, it is on the one hand flexible enough to meet the requirements of the different products produced, and on the other hand is still expressive enough to be used and extended by domain experts.

Based on this semi-generic operational database schema for industrial manufacturing processes, the contribution of this paper is to introduce and evaluate an analysis framework for data warehousing, which needs a minimum amount of adaption when the underlying operational database schema changes. The main idea is to use a descriptor table, which functions as a schema mapping (Bernstein and Melnik, 2007) between the operational schema and the analysis schema allowing to generate the ETL process needed to load data into the data warehouse.

The rest of this paper is organized as follows: section 2 describes the current work related to generic data models as well as automatic generation of ETL processes. Section 3 describes the architecture of our approach to automatically generate ETL processes for a semi-generic data model. Section 4 contains details of the implementation. Finally, section 5 concludes with an evaluation and intended further work.

\section{RELATED WORK}

In order to be able to automatically generate domain independent ETL processes from arbitrary data models a theoretical basis for schema matching is needed, as described in (Bernstein and Melnik, 2007). Modern ETL tools (Chaudhuri et al., 2011) provide such a
domain independent approach to data integration, but require the mappings to be manually engineered. Schema-less NoSql database management systems like, e.g., Bigtable (Chang et al., 2008) or semi-structured data models (Acharya et al., 2008) efficiently store NULL-values, thus mitigating the drawback of domain oriented data schemas of having many NULL values when comparing them to generic schemas like EAV. However, NoSql is targeted towards semi-structured mass data, it is not particularly suited to deal with strongly structured, relationship heavy data like, e.g., master data. This often leads to heterogeneous IT infrastructures with both NoSql and traditional relational database systems. Thus, it is still desirable for many companies to exclusively use a relational database management system.

Business intelligence development tools for ETL (Stumpner et al., 2012) typically use available metadata, e.g., constraints and foreign keys, to create templates which need to be further parameterized by the domain experts. In our approach, domain knowledge is specified by end users beforehand, our generator then uses this information to create the ETL processes without further adjustments needed by the end user. Thus, the domain metadata is available for all ETL processes to be developed in the future.

(Muñoz et al., 2009) presents an approach to automatic generation of ETL processes. It is based on the Model Driven Architecture (MDA) framework and generates Process Specific Models (PSM) from Process Independent Models (PIM) using Query View Transformations (QVT). One PIM describes a single ETL process and is completely implementation-independent. The PIM is the main source of documentation for the ETL process. In (Atigui et al., 2012) a framework to automatically integrate data warehouse and ETL design within the MDA is introduced. It is based on the Object Constraint Language (OCL). In the paper at hand, the descriptor table is closely related to the PIM, as it describes the ETL process in a platform independent way using classes, attributes and filter criteria, even though our example implementation is based on the relational data model. The descriptor table functions as a documentation of the ETL process, with the possibility of transforming the condensed representation of the table into a more human-readable format. Instead of process specific models, our approach uses SQL as a common language in the data warehousing world.

In (Skoutas and Simitsis, 2006), ontologies are used to specify structure and semantics of multiple data source schemata as well as the data warehouse schema. Using reasoning, conceptual ETL processes are then inferred automatically, which specify the transformation of one or more source schemata to the data warehouse schema. The main motivation for using ontologies is to overcome structural and semantic heterogeneity. Comparing this to our approach, we use a semi-generic data model for different products in a product line, where the non-generic, i.e., product specific parts are explicitly mapped via the descriptor table. Thus, because of our generic approach, we have no need for an inferred mapping of schemata. (Skoutas and Simitsis, 2006) is only concerned with the generation of conceptual ETL processes, a subsequent transformation into a platform dependent implementation is required.

(Khedri and Khosravi, 2013) proposes and implements a delta-oriented approach to handling variability in database schemata for software product lines. The start out with a core schema containing mandatory features that gets modified using delta scripts depending on with optional or alternative features are selected for a specific product. In contrast, our approach uses a strict separation of database objects which are common to all products, i.e., master data, and product specific parts of the database schema.

3 ARCHITECTURE

Figure 2 gives an overview of the data analysis architecture presented in this paper. Data is transformed from the operational database to the analysis database passing three different stages. The operational database is a relational database, the analysis database is implemented as an OLAP (on-line analytical processing) database (Chaudhuri et al., 2011). The first stage is responsible for dealing with activities specific to the operational database. The second step executes activities not dependent on the source or target database. The last stage is responsible for dealing with specifics of the analysis database. Thus, each stage is responsible for executing an arbitrary number of activities falling in one of three groups: operational database specific, independent and analysis database specific. When a new type of activity is needed, it can be implemented as a template for instantiation and reuse. Operational as well as analysis database specific activities are generated based on a descriptor table and use a interval definition table.

The main task of the operational database specific activities is to retrieve data from the operational database representing the specific product variation of interest and transform it into a domain independent data structure, in our case into an EAV model. To do so, at least a change data capture and staging activity must be implemented. The change data capture ac-
Figure 2: Overview of the data analysis architecture.

Independent activities are domain specific and perform transformations and calculations on the data which are required in the analysis model and uniformly applied to all product variations. They operate on an EAV data structure, which does not reflect any product specific variability at the schema level. Two activities implemented in this work are repeated measures and persistence. The repeated measures activity implements a logic to deal with measurements that are taken multiple times, that is often found in the industrial manufacturing domains. The activity logically groups measurements into measurement-cycles. New measurement-cycles start at certain events or actions within the production process, like applying a special treatment or a repair. Measurements may be taken as often as needed, but by the end of every measurement-cycle only the last measured value of a measurement type must be used in the analysis model as a reference for the respective measurement-cycle. That means, the measurement value may result from a previously performed measurement-cycle as well. This calculation, technically also known as last-non-empty function, is implemented as an independent activity and thus applied uniformly to all product variants (see section 4.2). Even though last-non-empty is a feature present in most analysis front ends, our template is independent and can be used with all OLAP front ends, regardless of whether a last-non-empty function is available.

Similar to the repeated measures activity, the persistence activity is designed as an independent activity, that is responsible for persisting the data into a table. It provides a mechanism for already loaded data, i.e. apply insert, update or merge operations.

Finally, analysis database specific activities build the connection to the analysis database. Because these activities represent product specific variations, the activities are generated based on the descriptor table and use the interval definition table. For example, the pivot activity transforms the data from the product independent EAV model to a more expressive and explicit analysis model.

OLAP is often applied in analysis databases. In standard OLAP only dimensions are allowed to be used at the axis position of a query. As numerical values must be modeled as facts, correlation analysis between numerical measures can not be performed, as it would require facts being placed at the axis position. To overcome this drawback, some front end tools provide proprietary solutions for this problem, but in order to be able to use standard OLAP front end tools, the interval dimension activity performs a discretization of the numerical measurements by mapping the values to corresponding interval dimension elements. Again, the interval dimension activity calculates the dimension intervals according to the specification in the descriptor table (see section 4.3).
4 IMPLEMENTATION

The architecture introduced in section 3 has been prototypically implemented using Microsoft SQL Server 2008 Database, Integration Services and Analysis Services.

4.1 Descriptor Table

The descriptor table captures the variability in the operational database, as depicted in figure 1, with respect to the requirements of the analysis model. For every measure in the analysis model it defines: (i) the location of the data in operational database, (ii) the constraints that must be applied when querying the operational database to get meaningful results, and (iii) an interval specification for the measures in the analysis model. Table 1 shows an example descriptor table. Column `M_Type` represents the measure in the analysis model. `TABNAME` and `COLNAME` represent the table and column where the measure can be found in the operational database. `CHANNELNB` and `CHANNELTYPE` represent the filter conditions applied to the master data subset of the operational database when the measurement values are retrieved. `INTVL` represents the interval specification applied when the measures are loaded into the analysis database (for further details see section 4.3).

Based on the descriptor table shown in table 1, the following data access query is generated in the staging activity an installed as a data access view in the staging area:

```
SELECT P.SERIALNB, 
  D.MTYPE 
CASE D.TABNAME+'.'+D.COLNAME 
  WHEN 'MEASURE.STARTTIME' THEN 
    CONVERT(varchar,MEASURE.STARTIME) 
  WHEN 'MEASUREDETAIL.REF' THEN 
    CONVERT(varchar,MEASUREDETAIL.REF) 
  WHEN 'MEASUREDETAIL.ACTUAL' THEN 
    CONVERT(varchar,MEASUREDETAIL.ACTUAL) 
END as MVALUE 
FROM 
  PRODUCT P, 
  MEASURE M, 
  MEASUREDETAIL MD, 
  DESCRIPTOR D 
WHERE P.ID = M.PID 
  and M.ID = MD.MID 
  and M.CHANNELNB = D.CHANNELNB 
  and M.CHANNELTYPE = D.CHANNELTYPE 
```

The query selects tables and columns, and applies filters according to the descriptor table. Furthermore, it defines the level of granularity required in the analysis model. For the reason of clarity, the pivot into the domain independent EAV data structure is performed by joining the DESCRIPTOR table along with the case statement. An optimized query omits joining the DESCRIPTOR table at all, utilizing SQL pivot operations, thus increasing the performance.

4.2 Repeated Measurements

Table 2 shows an example of measured values stored in the operational database. The column SERIALNB identifies the entity or product being measured, MCYCLE the assigned measurement cycle for the measurement, MTYPE the measurement type or attribute being measured and MVALUE the measured value. The query that enriches every measurement cycle with the last available measurement for every measurement type is given below:

```
SELECT TMP.SERIALNB, 
  TMP.MCYC, 
  TMP.MTYPE, 
  TMP.MVALUE 
FROM ( 
  SELECT T1_DATA.SERIALNB, 
    T1_CYC.MCYC, 
    T1_DATA.MTYPE, 
    T1_DATA.MVALUE, 
    rank() OVER (partition BY T1_DATA.SERIALNB, 
    T1_CYC.MCYC, 
    T1_DATA.MTYPE 
    ORDER BY T1_DATA.MCYC DESC) AS POS 
  FROM 
  T1 T1_DATA INNER JOIN 
  ( SELECT DISTINCT SERIALNB, MCYCLE FROM T1) T1_CYC 
  ON T1_DATA.SERIALNB = T1_CYC.SERIALNB AND 
  T1_DATA.MCYCLE <= T1_CYC.MCYCLE 
) TMP 
WHERE TMP.POS = 1 
```

The query performs a self join of all measured values with the corresponding serial number and the same or a previous measurement cycle. Then a ranking is performed on a descending sort order of the measurement cycle, yielding to the rank of 1 for the last performed measurement. Table 3 shows the result of the query. Rows added by the query are depicted with grey background color. Table 4 presents the result pivoted by SERIALNB and MCYCLE, showing every MTYPE in a separate column, as performed in the pivoting activity of the architecture described in section 3.

4.3 Interval Dimensions

The interval dimensions are implemented using an interval definition table intvlParams and two functions uf_SelectIntvlId and uf_DimInterval. Table 5 shows an example interval definition table for...
Table 1: Descriptor table DESCRIPTOR.

<table>
<thead>
<tr>
<th>MTYPE</th>
<th>TABNAME</th>
<th>COLNAME</th>
<th>CHANNELNB</th>
<th>CHANNELTYPE</th>
<th>INTVL</th>
</tr>
</thead>
<tbody>
<tr>
<td>A</td>
<td>MEASURE</td>
<td>STARTTIME</td>
<td>10</td>
<td>E</td>
<td></td>
</tr>
<tr>
<td>B</td>
<td>MEASUREDETAIL</td>
<td>REF</td>
<td>1</td>
<td>S</td>
<td>INVTL-B</td>
</tr>
<tr>
<td>C</td>
<td>MEASUREDETAIL</td>
<td>ACTUAL</td>
<td>10</td>
<td>E</td>
<td>INVTL-C</td>
</tr>
</tbody>
</table>

Figure 3: Correlation analysis using interval dimensions for measurement type B and C.

Table 2: Measured values stored in the operational database.

<table>
<thead>
<tr>
<th>SERIALNB</th>
<th>MCYCLE</th>
<th>MTYPE</th>
<th>MVALUE</th>
</tr>
</thead>
<tbody>
<tr>
<td>1</td>
<td>0</td>
<td>A</td>
<td>17:30</td>
</tr>
<tr>
<td>1</td>
<td>1</td>
<td>B</td>
<td>7.4</td>
</tr>
<tr>
<td>1</td>
<td>2</td>
<td>C</td>
<td>365</td>
</tr>
<tr>
<td>2</td>
<td>0</td>
<td>A</td>
<td>17:40</td>
</tr>
<tr>
<td>2</td>
<td>0</td>
<td>B</td>
<td>6.3</td>
</tr>
<tr>
<td>2</td>
<td>1</td>
<td>B</td>
<td>6.5</td>
</tr>
<tr>
<td>2</td>
<td>1</td>
<td>C</td>
<td>302</td>
</tr>
<tr>
<td>2</td>
<td>2</td>
<td>A</td>
<td>17:50</td>
</tr>
<tr>
<td>2</td>
<td>2</td>
<td>B</td>
<td>6.5</td>
</tr>
<tr>
<td>2</td>
<td>2</td>
<td>C</td>
<td>302</td>
</tr>
</tbody>
</table>

Table 3: Last measured values added to measurement cycles.

<table>
<thead>
<tr>
<th>SERIALNB</th>
<th>MCYCLE</th>
<th>MTYPE</th>
<th>MVALUE</th>
</tr>
</thead>
<tbody>
<tr>
<td>1</td>
<td>0</td>
<td>A</td>
<td>17:30</td>
</tr>
<tr>
<td>1</td>
<td>1</td>
<td>A</td>
<td>17:30</td>
</tr>
<tr>
<td>1</td>
<td>1</td>
<td>B</td>
<td>7.4</td>
</tr>
<tr>
<td>1</td>
<td>2</td>
<td>A</td>
<td>17:30</td>
</tr>
<tr>
<td>1</td>
<td>2</td>
<td>B</td>
<td>7.4</td>
</tr>
<tr>
<td>1</td>
<td>2</td>
<td>C</td>
<td>365</td>
</tr>
<tr>
<td>2</td>
<td>0</td>
<td>A</td>
<td>17:40</td>
</tr>
<tr>
<td>2</td>
<td>0</td>
<td>B</td>
<td>6.3</td>
</tr>
<tr>
<td>2</td>
<td>1</td>
<td>A</td>
<td>17:40</td>
</tr>
<tr>
<td>2</td>
<td>1</td>
<td>B</td>
<td>6.5</td>
</tr>
<tr>
<td>2</td>
<td>1</td>
<td>C</td>
<td>302</td>
</tr>
<tr>
<td>2</td>
<td>2</td>
<td>A</td>
<td>17:50</td>
</tr>
<tr>
<td>2</td>
<td>2</td>
<td>B</td>
<td>6.5</td>
</tr>
<tr>
<td>2</td>
<td>2</td>
<td>C</td>
<td>302</td>
</tr>
</tbody>
</table>

Table 4: Pivoted raw data.

<table>
<thead>
<tr>
<th>SERIALNB</th>
<th>MCYCLE</th>
<th>A</th>
<th>B</th>
<th>C</th>
</tr>
</thead>
<tbody>
<tr>
<td>1</td>
<td>0</td>
<td>17:30</td>
<td>7.4</td>
<td></td>
</tr>
<tr>
<td>1</td>
<td>1</td>
<td>17:30</td>
<td>7.4</td>
<td>365</td>
</tr>
<tr>
<td>2</td>
<td>0</td>
<td>17:40</td>
<td>6.3</td>
<td></td>
</tr>
<tr>
<td>2</td>
<td>0</td>
<td>17:40</td>
<td>6.3</td>
<td>302</td>
</tr>
<tr>
<td>2</td>
<td>1</td>
<td>17:50</td>
<td>6.3</td>
<td>302</td>
</tr>
</tbody>
</table>

Table 5: Interval definition table intvlParams.

<table>
<thead>
<tr>
<th>INTVL</th>
<th>LBND</th>
<th>UBND</th>
<th>STEP1</th>
<th>STEP2</th>
</tr>
</thead>
<tbody>
<tr>
<td>INVTL-B</td>
<td>-10</td>
<td>10</td>
<td>1</td>
<td>0.1</td>
</tr>
<tr>
<td>INVTL-C</td>
<td>200</td>
<td>400</td>
<td>20</td>
<td>5</td>
</tr>
</tbody>
</table>

The function $uf\_SelectIntvlId(intvl, v)$ returns the interval dimension identifier id for the given value v in the interval intvl. The function is defined as:

$$id = \begin{cases} 
0, & \text{if } v \leq \text{lbnd} \\
1 + (\text{ubnd} - \text{lbnd})/\text{step2}, & \text{if } v > \text{ubnd} \\
[(v - \text{ubnd})/\text{step2}], & \text{otherwise}
\end{cases}$$

The function $uf\_DimInterval(intvl)$ returns a table containing all interval dimension elements for the certain interval. Table 6 shows the generated interval dimension for INTVL-B. The calculation of the identifier ID provided in the table is specified in the column STEP2. If the analysis model requires finer intervals, additional levels may be added. The function $uf\_SelectIntvlId(intvl, v)$ returns the interval dimension identifier id for the given value v in the interval intvl. The function is defined as:

$$id = \begin{cases} 
0, & \text{if } v \leq \text{lbnd} \\
1 + (\text{ubnd} - \text{lbnd})/\text{step2}, & \text{if } v > \text{ubnd} \\
[(v - \text{ubnd})/\text{step2}], & \text{otherwise}
\end{cases}$$

The function $uf\_DimInterval(intvl)$ returns a table containing all interval dimension elements for the certain interval. Table 6 shows the generated interval dimension for INTVL-B. The calculation of the identifier ID provided in the table is
Table 6: Interval dimension table for interval INTVL-B.

<table>
<thead>
<tr>
<th>ID</th>
<th>DESC1</th>
<th>SORT1</th>
<th>LBD1</th>
<th>UBND1</th>
<th>DESC2</th>
<th>SORT2</th>
<th>LBND2</th>
<th>UBND2</th>
</tr>
</thead>
<tbody>
<tr>
<td>0</td>
<td>≤10.0</td>
<td>0</td>
<td>NULL</td>
<td>-10.0</td>
<td>≤10.0</td>
<td>0</td>
<td>NULL</td>
<td>-10.0</td>
</tr>
<tr>
<td>...</td>
<td>...</td>
<td>...</td>
<td>...</td>
<td>...</td>
<td>...</td>
<td>...</td>
<td>...</td>
<td>...</td>
</tr>
<tr>
<td>10</td>
<td>-10.0 to -9.0</td>
<td>1</td>
<td>-10.0</td>
<td>-9.0</td>
<td>-9.1 to -9.0</td>
<td>10</td>
<td>-9.1</td>
<td>-9.0</td>
</tr>
<tr>
<td>11</td>
<td>-9.0 to -8.0</td>
<td>2</td>
<td>-9.0</td>
<td>-8.0</td>
<td>-9.0 to -8.9</td>
<td>11</td>
<td>-9.0</td>
<td>-8.9</td>
</tr>
<tr>
<td>...</td>
<td>...</td>
<td>...</td>
<td>...</td>
<td>...</td>
<td>...</td>
<td>...</td>
<td>...</td>
<td>...</td>
</tr>
<tr>
<td>200</td>
<td>9.0 to 10.0</td>
<td>20</td>
<td>9.0</td>
<td>10.0</td>
<td>9.9 to 10.0</td>
<td>200</td>
<td>9.9</td>
<td>10.0</td>
</tr>
<tr>
<td>201</td>
<td>&gt;10.0</td>
<td>201</td>
<td>10.0</td>
<td>NULL</td>
<td>&gt;10.0</td>
<td>201</td>
<td>10.0</td>
<td>NULL</td>
</tr>
</tbody>
</table>

Based on the same algorithm used by the function uf_SelectIntvlId, i.e., the identifier returned by the function uf_SelectIntvlId represents the lookup key to the interval dimension element.

Interval dimensions are calculated when the OLAP model is processed, thus the interval dimensions are not materialized in the analysis database. Changes at the interval specification table only require a reprocessing of the OLAP model. Figure 3 shows an example correlations analysis based on interval dimensions.

5 CONCLUSIONS

Focusing on the industrial manufacturing domain using a basic descriptor table allowed us to quickly automatically generate an ETL process and its corresponding analysis model that reflects the different analysis requirement of all product variations. When dealing with changing products, quickly providing analysis models for new products is crucial in the industry.

The approach in this paper uses a relational descriptor table to automatically generate ETL processes for semi-generic operational database schemas. Filters based on constants on the operational database for retrieving data as well as interval dimensions used in the analysis model can be specified to accommodate the differences in the analysis requirements. The resulting analysis model does not depend on proprietary client tool features, thus allows to perform analysis with standard OLAP tools. The modular organization of the architecture allows the creation of additional activities when needed. The distinction between dependent and independent activities ensures the decoupling of the analysis database from the operational database.

Repeated measures and interval dimension represented the core operations in our application scenario. Implementing them as separate and self-contained activities allows them to be easily reused for other product variations.

Nevertheless, in this work data have been loaded from a single data source into the data warehouse. If data have to be integrated from multiple sources, data quality issues (Chaudhuri et al., 2011) like duplicates or inconsistent representations may occur. Moreover, the expressiveness of the description language used should be increased, i.e., introducing variables and conditions to be used in filter specifications.

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